Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/527,894	YIN ET AL.	
Examiner	Art Unit	
Linh T. Nguyen	2627	

	SEAR	CHED	
Class	Subclass	Date	Examiner
369	53.34	6/25/2007	LN
369	59.21	6/25/2007	LN
369	59.22	6/25/2007	LN
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	searched on	6/25/2007	LN

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
East keyword searched.	6/25/2007	LN
Clasisification searched.	6/25/2007	LN
East searched on JPO; EPO FPRS; DERWENT; IBM_TDB.	6/25/2007	LN
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